Power MOSFET -3.05 Amps, -30 Volts

Dual P-Channel SOIC-8

Features

- High Efficiency Components in a Dual SOIC-8 Package
- High Density Power MOSFET with Low R_{DS(on)}
- Miniature SOIC-8 Surface Mount Package Saves Board Space
- Diode Exhibits High Speed with Soft Recovery
- I_{DSS} Specified at Elevated Temperature
- Avalanche Energy Specified
- Mounting Information for the SOIC-8 Package is Provided
- AEC-O101 Qualified NVMD3P03R2G
- These Devices are Pb-Free and are RoHS Compliant

Applications

- DC-DC Converters
- Low Voltage Motor Control
- Power Management in Portable and Battery-Powered Products, i.e.:
 Computers, Printers, PCMCIA Cards, Cellular & Cordless Telephones

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

| Rating | Symbol | Value | Unit |
|---|--|---------------------------------------|---------------------|
| Drain-to-Source Voltage | V_{DSS} | -30 | V |
| Gate-to-Source Voltage - Continuous | V_{GS} | ±20 | V |
| Thermal Resistance – Junction-to-Ambient (Note 1) Total Power Dissipation @ T _A = 25°C Continuous Drain Current @ 25°C Continuous Drain Current @ 70°C Pulsed Drain Current (Note 4) | R _{θJA} P _D I _D I _D | 171 0.73 -2.34 -1.87 -8.0 | °C/W W A A |
| Thermal Resistance – Junction-to-Ambient (Note 2) Total Power Dissipation @ T _A = 25°C Continuous Drain Current @ 25°C Continuous Drain Current @ 70°C Pulsed Drain Current (Note 4) | R _{θJA} P _D I _D I _D | 100 1.25 -3.05 -2.44 -12 | °C/W W A A |
| Thermal Resistance – Junction-to-Ambient (Note 3) Total Power Dissipation @ T _A = 25°C Continuous Drain Current @ 25°C Continuous Drain Current @ 70°C Pulsed Drain Current (Note 4) | R _{θJA} P _D I _D I _D | 62.5 2.0 -3.86 -3.1 -15 | °C/W W A A |
| Operating and Storage Temperature Range | T _J , T _{stg} | -55 to +150 | °C |
| Single Pulse Drain-to-Source Avalanche Energy – Starting $T_J = 25^{\circ}\text{C}$ ($V_{DD} = -30 \text{ Vdc}, V_{GS} = -4.5 \text{ Vdc}, \text{ Peak I}_L$ = -7.5 Apk, L = 5 mH, $R_G = 25 \Omega$) | E _{AS} | 140 | mJ |
| Maximum Lead Temperature for Soldering Purposes, 1/8" from case for 10 seconds | TL | 260 | °C |

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

- 1. Minimum FR-4 or G-10 PCB, t = Steady State.
- Mounted onto a 2" square FR-4 Board (1 in sq, 2 oz Cu 0.06" thick single sided), t = steady state.
- Mounted onto a 2" square FR-4 Board (1 in sq, 2 oz Cu 0.06" thick single sided), t ≤ 10 seconds.
- 4. Pulse Test: Pulse Width = 300 μs, Duty Cycle = 2%.

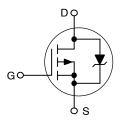


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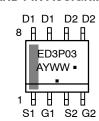
| V _{DSS} | R _{DS(ON)} Typ | I _D Max |
|------------------|-------------------------|--------------------|
| -30 V | 85 mΩ @ –10 V | –3.05 A |

P-Channel





MARKING DIAGRAM* AND PIN ASSIGNMENT



ED3P03= Specific Device Code

A = Assembly Location

Y = Year WW = Work Week

= Pb-Free Package

(Note: Microdot may be in either location)
*For additional marking information, refer to
Application Note AND8002/D.

ORDERING INFORMATION

| Device | Package | Shipping [†] |
|-------------|---------------------|-----------------------|
| NTMD3P03R2G | SOIC-8 (Pb-Free) | 2500 / Tape & Reel |
| NVMD3P03R2G | SOIC-8 (Pb-Free) | 2500 / Tape & Reel |

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D

ELECTRICAL CHARACTERISTICS (T₁ = 25°C unless otherwise noted) (Note 5)

| Characteristic | | | Min | Тур | Max | Unit |
|--|---|---------------------|-------------|----------------|---------------------|--------------|
| OFF CHARACTERISTICS | | | | | | |
| Drain-to-Source Breakdown Voltage (V _{GS} = 0 Vdc, I _D = -250 μAdc) Temperature Coefficient (Positive) | | | -30 - | - -30 | _ _ | Vdc mV/°C |
| Zero Gate Voltage Drain Current $ (V_{DS} = -24 \text{ Vdc}, V_{GS} = 0 \text{ Vdc}, T_J = 25^{\circ}\text{C}) $ $ (V_{DS} = -24 \text{ Vdc}, V_{GS} = 0 \text{ Vdc}, T_J = 125^{\circ}\text{C}) $ $ (V_{DS} = -30 \text{ Vdc}, V_{GS} = 0 \text{ Vdc}, T_J = 25^{\circ}\text{C}) $ $ (V_{DS} = -30 \text{ Vdc}, V_{GS} = 0 \text{ Vdc}, T_J = 25^{\circ}\text{C}) $ | | | - - - | - - - | -1.0 -20 -2.0 | μAdc |
| Gate-Body Leakage Current (V _{GS} = -20 Vdc, V _{DS} = 0 Vdc) | | | - | - | -100 | nAdc |
| Gate-Body Leakage Current (V _{GS} = +20 Vdc, V _{DS} = 0 Vdc) | | | - | - | 100 | nAdc |
| ON CHARACTERISTICS | | | | | | • |
| Gate Threshold Voltage $(V_{DS} = V_{GS}, I_D = -250 \ \mu Adc)$ Temperature Coefficient (Negative) | | | -1.0 - | -1.7 3.6 | -2.5 - | Vdc |
| Static Drain-to-Source On-State Resistance $(V_{GS} = -10 \text{ Vdc}, I_D = -3.05 \text{ Adc})$ $(V_{GS} = -4.5 \text{ Vdc}, I_D = -1.5 \text{ Adc})$ | | | - - | 0.063 0.090 | 0.085 0.125 | Ω |
| Forward Transconductance (V _{DS} = -15 Vdc, I _D = -3.05 Adc) | | | - | 5.0 | - | Mhos |
| OYNAMIC CHARACTERISTICS | | | | | | |
| Input Capacitance | | C _{iss} | - | 520 | 750 | pF |
| Output Capacitance | $(V_{DS} = -24 \text{ Vdc}, V_{GS} = 0 \text{ Vdc}, $ f = 1.0 MHz) | C _{oss} | - | 170 | 325 | |
| Reverse Transfer Capacitance |] | C _{rss} | _ | 70 | 135 | |
| SWITCHING CHARACTERISTICS (| Notes 6 and 7) | | | | | |
| Turn-On Delay Time | | t _{d(on)} | _ | 12 | 22 | ns |
| Rise Time | $(V_{DD} = -24 \text{ Vdc}, I_D = -3.05 \text{ Adc},$ | t _r | - | 16 | 30 | |
| Turn-Off Delay Time | $V_{GS} = -10 \text{ Vdc},$ $R_G = 6.0 \Omega)$ | t _{d(off)} | - | 45 | 80 | |
| Fall Time | | t _f | - | 45 | 80 | |
| Turn-On Delay Time | | t _{d(on)} | - | 16 | - | ns |
| Rise Time | $(V_{DD} = -24 \text{ Vdc}, I_D = -1.5 \text{ Adc},$ | t _r | - | 42 | - | |
| Turn-Off Delay Time | $V_{GS} = -4.5 \text{ Vdc},$ $R_G = 6.0 \Omega)$ | t _{d(off)} | _ | 32 | - | |
| Fall Time | | t _f | _ | 35 | - | |
| Total Gate Charge | (V _{DS} = -24 Vdc, | Q _{tot} | - | 16 | 25 | nC |
| Gate-Source Charge | $V_{GS} = -10 \text{ Vdc},$ | Q _{gs} | - | 2.0 | _ | |
| Gate-Drain Charge | I _D = -3.05 Adc) | Q _{gd} | _ | 4.5 | _ | |
| BODY-DRAIN DIODE RATINGS (No | ote 6) | | | | | • |
| Diode Forward On-Voltage | $(I_S = -3.05 \text{ Adc}, V_{GS} = 0 \text{ V})$ $(I_S = -3.05 \text{ Adc}, V_{GS} = 0 \text{ V}, T_J = 125^{\circ}\text{C})$ | V _{SD} | - | -0.96 -0.78 | -1.25 - | Vdc |
| Reverse Recovery Time | $ (I_S = -3.05 \text{ Adc, V}_{GS} = 0 \text{ Vdc,} $ $ dI_S/dt = 100 \text{ A/}\mu\text{s}) $ | t _{rr} | - | 34 | - | ns |
| | | ta | - | 18 | _ | |
| | | t _b | - | 16 | _ | |
| Reverse Recovery Stored Charge | | Q _{RR} | _ | 0.03 | _ | μС |

- 5. Handling precautions to protect against electrostatic discharge is mandatory.
 6. Indicates Pulse Test: Pulse Width = 300 μs max, Duty Cycle = 2%.
- 7. Switching characteristics are independent of operating junction temperature.

TYPICAL ELECTRICAL CHARACTERISTICS

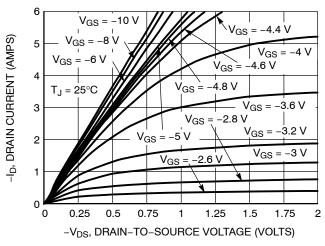


Figure 1. On-Region Characteristics

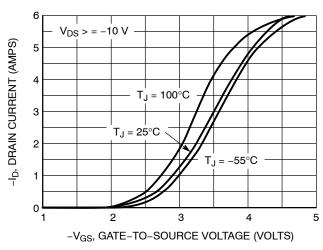


Figure 2. Transfer Characteristics

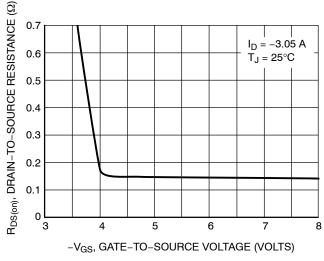


Figure 3. On-Resistance vs. Gate-to-Source Voltage

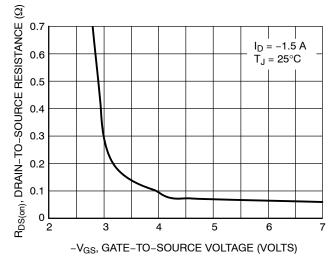


Figure 4. On-Resistance vs. Gate-to-Source Voltage

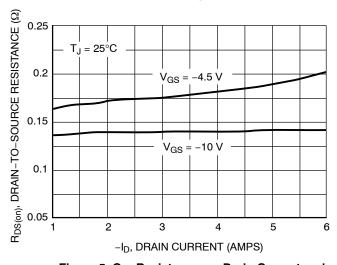


Figure 5. On-Resistance vs. Drain Current and Gate Voltage

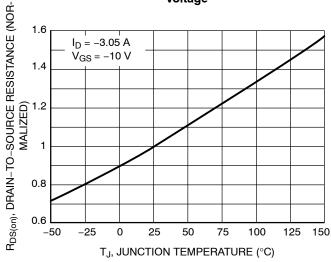
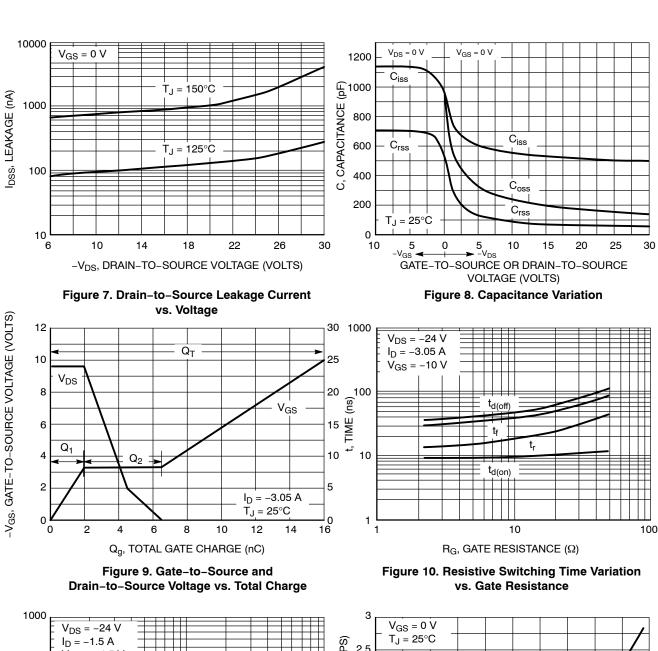


Figure 6. On Resistance Variation with Temperature



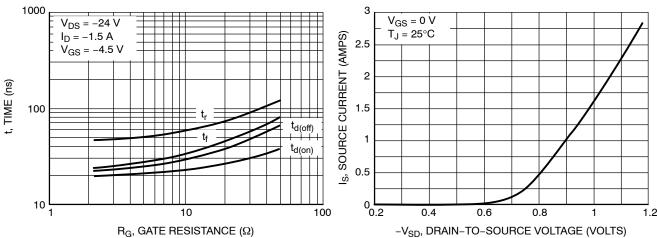
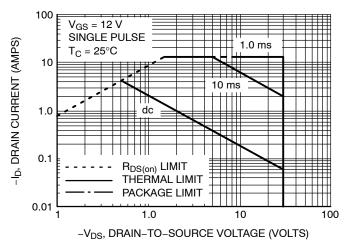


Figure 11. Resistive Switching Time Variation vs. Gate Resistance

Figure 12. Diode Forward Voltage vs. Current



 $\begin{array}{c|c} & & & \\ & & & \\ & & & \\ & & & \\ & & & \\ & & & \\ & & \\ & & \\ & & \\ & & \\ & & \\ & & \\ & & \\ & & \\ & & \\ & & \\ & \\ & & \\$

Figure 13. Maximum Rated Forward Biased Safe Operating Area

Figure 14. Diode Reverse Recovery Waveform

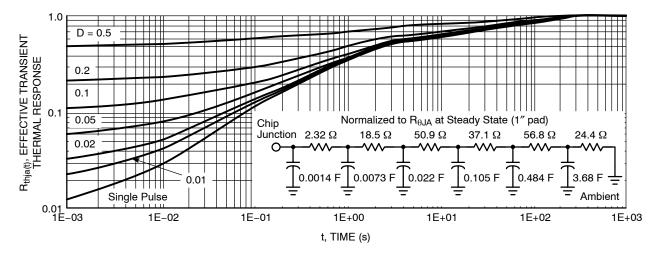
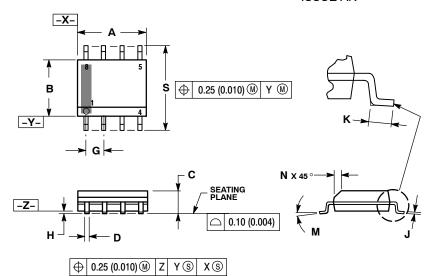


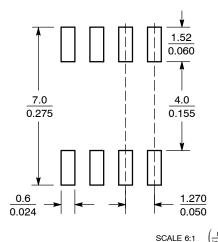
Figure 15. FET Thermal Response

PACKAGE DIMENSIONS

SOIC-8 NB CASE 751-07 **ISSUE AK**



SOLDERING FOOTPRINT*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
- ANSI Y14.5M, 1982.
 CONTROLLING DIMENSION: MILLIMETER.
 DIMENSION A AND B DO NOT INCLUDE
 MOLD PROTRUSION.
 MAXIMUM MOLD PROTRUSION 0.15 (0.006)
- 5. DIMENSION D DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR
 PROTRUSION SHALL BE 0.127 (0.005) TOTAL IN EXCESS OF THE D DIMENSION AT
- MAXIMUM MATERIAL CONDITION. 751-01 THRU 751-06 ARE OBSOLETE. NEW STANDARD IS 751-07

| | MILLIMETERS | | INCHES | | |
|-----|-------------|------|-------------|-------|--|
| DIM | MIN | MAX | MIN | MAX | |
| Α | 4.80 | 5.00 | 0.189 | 0.197 | |
| В | 3.80 | 4.00 | 0.150 | 0.157 | |
| C | 1.35 | 1.75 | 0.053 | 0.069 | |
| D | 0.33 | 0.51 | 0.013 | 0.020 | |
| G | 1.27 BSC | | 0.050 BSC | | |
| Η | 0.10 | 0.25 | 0.004 0.010 | | |
| J | 0.19 | 0.25 | 0.007 | 0.010 | |
| K | 0.40 | 1.27 | 0.016 | 0.050 | |
| М | 0 ° | 8 ° | 0 ° | 8 ° | |
| N | 0.25 | 0.50 | 0.010 | 0.020 | |
| S | 5.80 | 6.20 | 0.228 | 0.244 | |

STYLE 11:

SOURCE 1 PIN 1.

- 2. GATE 1
- SOURCE 2
- GATE 2 DRAIN 2 5.
- 6. DRAIN 2
- DRAIN 1
- DRAIN 1

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